## Application/Control No. 10/813,889 Applicant(s)/Patent Under Reexamination PRAKASH ET AL. Examiner John Chavis Applicant(s)/Patent Under Reexamination PRAKASH ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0158354	07-2006	Aberg et al.	341/050
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## **FOREIGN PATENT DOCUMENTS**

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